

# CN25 Nanofabrication Facility Overview on Tools & Processes

**Nanofabrication Facility Officer:** 

Dr. Raúl Pérez Rodríguez

# Nanofabrication Facility Overview on Tools & Processes



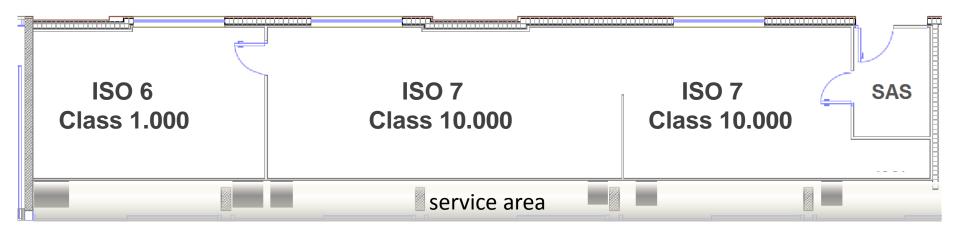
#### Topics of the day

- 1. Facility overview
- 2. Systems and processes for:
  - 1. Thin film deposition
  - 2. Plasma dry etching
  - 3. UV Photolithography
  - 4. Ebeam lithography

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#### Cleanroom environment

Cleanroom area ~ 100m<sup>2</sup>









# Institut Català de Nanociència i Nanotecnologia

#### Cleanroom environment

Cleanroom area ~ 100m<sup>2</sup>



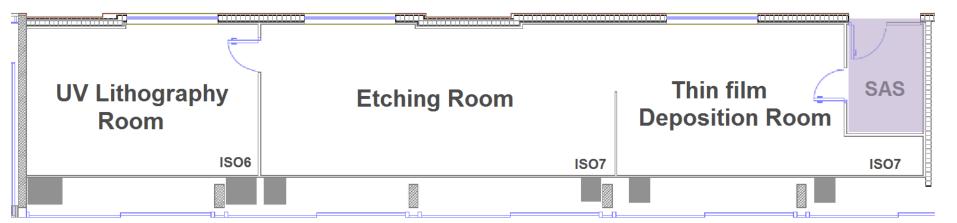










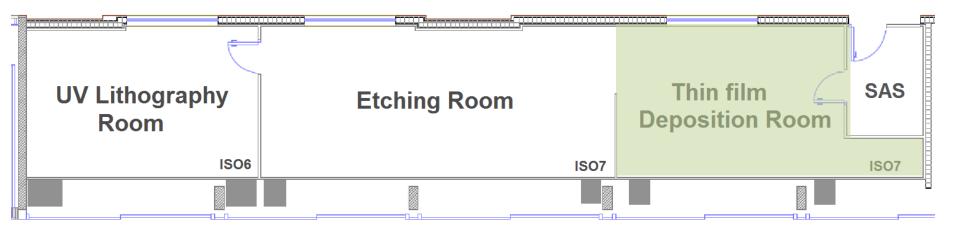






#### Facility installed systems







#### equipped with:

- Ebeam evaporator
- Ebeam/sputter evaporator
- ALD system

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#### Thin film deposition

#### **Ebeam evaporator**

Manufacturer: AJA International Inc.

Model: ATC-8E Orion

• 10kV HV source (Telemark)

• Substrates size: up to 4" wafers

Rotation & tilt holder.

- 6 material pockets source (rotary pocket) for deposition of multilayers.
- Crystal quartz thickness monitor (INFICON).
- Cryopumped main chamber, up to 1x10-8 mbar
- Turbopumped loadlock chamber, up to 2x10-7 mbar





# Thin film deposition

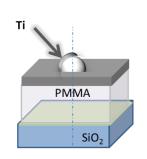


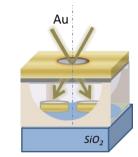
### **Examples**

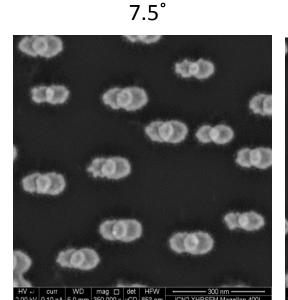
#### **Gold nanogap antennas**

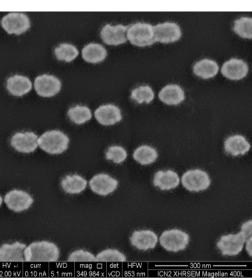
- Tilted evaporation of sacrifical layer (elliptical mask)
- Tilted gold evaporation



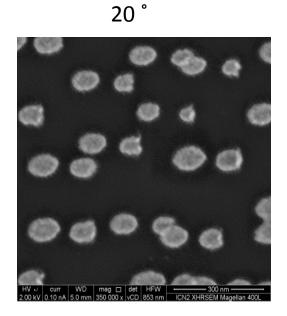








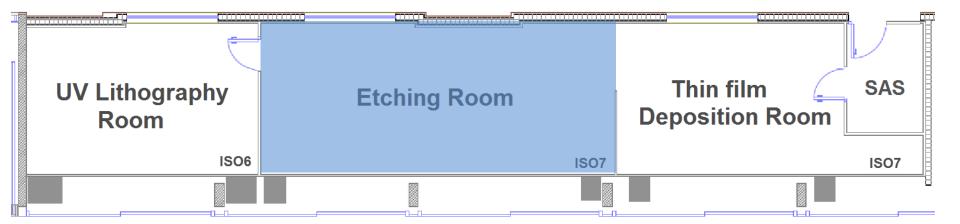
10°



(courtesy of Carmen Estevez NanoB2A group)

#### Facility installed systems







#### equipped with:

- ICP-RIE plasma etching
- O2 Plasma cleaner
- Fumehood (wet etching)

#### Plasma dry etching



#### **ICP-RIE Plasma etching**

Dry etching for pattern transfer.

Manufacturer: Oxford Instruments

Model: PlasmaPro Cobra 100

Substrate size: up to 8"

• ICP Power: up to 3kW

RIE Power: up to 600W

He backside substrate cooling

• Table temperature: -10C - 60C

Low pressure strike

8 gases line:
 O<sub>2</sub>, Ar, He, N<sub>2</sub>, CHF<sub>3</sub>, SF<sub>6</sub>, C<sub>4</sub>F<sub>8</sub>, CF<sub>4</sub>

Laser endpoint detector





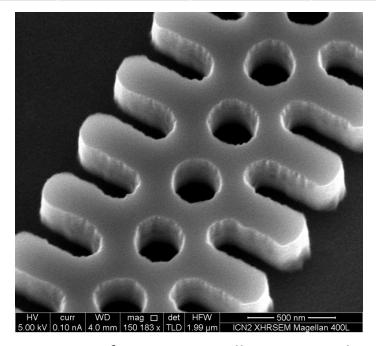
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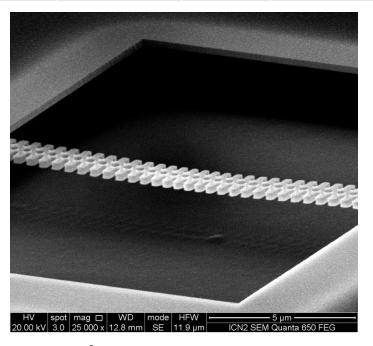
# Plasma dry etching

#### Recipes

#### Si etching

| Gas  | Flow      | Pressure | HF power | ICP Power | Time | Etched depth |
|--|-----------|----------|----------|-----------|------|--------------|
| C <sub>4</sub> F <sub>8</sub> /SF <sub>6</sub> | 30/10sccm | 25mTorr  | 35W      | 1200W     | 1min | 300nm        |





courtesy of Maria G., Guillermo A. and Marianna S. from P2N group

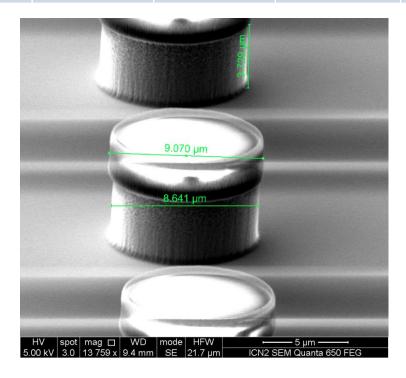
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# Plasma dry etching

#### **Recipes**

#### Si etching

| Gas  | Flow      | Pressure | HF power | ICP Power | Time  | Etched depth |
|--|-----------|----------|----------|-----------|-------|--------------|
| C <sub>4</sub> F <sub>8</sub> /SF <sub>6</sub> | 60/35sccm | 8mTorr   | 40W      | 1500W     | 10min | 3,8um        |



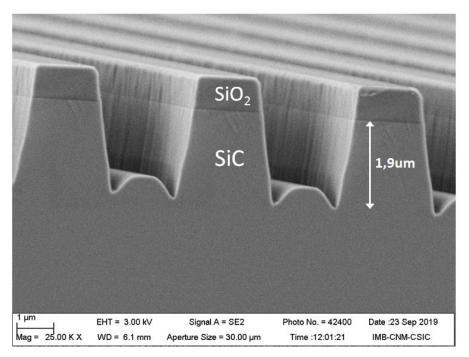
# Plasma dry etching



#### Recipes

#### **SiC etching**

| Gas             | Flow   | Pressure | HF power | ICP Power | Time | Etched depth  |
|-----------------|--------|----------|----------|-----------|------|---------------|
| SF <sub>6</sub> | 60sccm | 8mTorr   | 60W      | 1250W     | 8min | <b>1,9</b> um |



courtesy of Philippe Godignon from IMB-CNM

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#### Plasma dry etching

#### Recipes

#### SiN etching

| Gas                             | Flow      | Pressure | HF power | ICP Power | Time | Etched depth |
|---------------------------------|-----------|----------|----------|-----------|------|--------------|
| CF <sub>4</sub> /O <sub>2</sub> | 50/10sccm | 8mTorr   | 50W      | 500W      | 2min | 310nm        |

#### Au etching

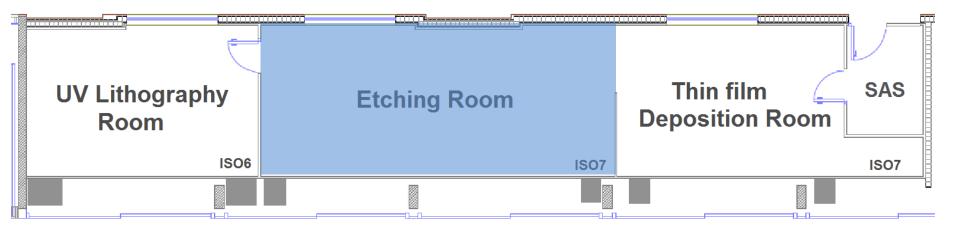
| Gas | Flow   | Pressure | HF power | ICP Power | Time | Etched depth |
|-----|--------|----------|----------|-----------|------|--------------|
| Ar  | 60sccm | 6mTorr   | 30W      | 300W      | 2min | 60nm         |

#### **Graphene etching**

| Gas                | Flow      | Pressure | HF power | ICP Power | Time | Etched depth |
|--------------------|-----------|----------|----------|-----------|------|--------------|
| O <sub>2</sub> /Ar | 40/20sccm | 80mTorr  | 20W      | 0W        | 2min | nm           |

#### Facility installed systems







#### equipped with:

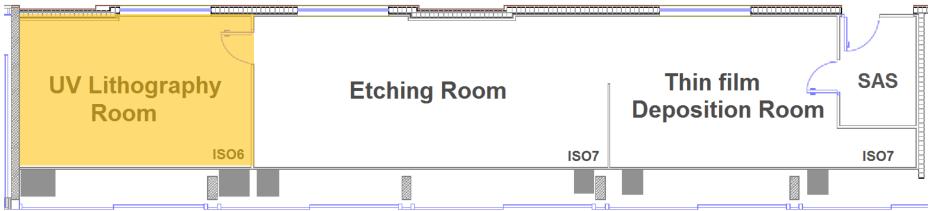
- ICP-RIE plasma etching
- O2 Plasma cleaner
- Fumehood (wet etching)

#### Characterization equipment:

- Stylus Profilometer (KLA-Tencor)
- 3D Optical Profiler (Filmetrics)

#### Facility installed systems







#### equipped with:

- Direct Write Laser Lithography
- UV Mask Aligner
- Fumehood 1 (Spinner + 3 Hotplates)
- Fumehood 2 (Vacc. Dess. + Sonicator)
- Optical Microscope (x10, x50)
- Oven (300C)
- Fridge

#### UV photolithography



#### **UV** Exposure

#### Mask aligner



Manufacturer: KLOE

Model: KUB 3

• Substrates: from small pieces to 4"

Mask Size: 5"x"5"

• UV LED source: 365nm

• Resolution: 2um

• Alignment accuracy: 3um

#### **Direct Write Laser**



Manufacturer: KLOE Model: Dilase 250

• Substrates: from small pieces to 4"

• UV source: 375nm

• Laser spot size: 1um

• Writing speed: up to 100mm/s

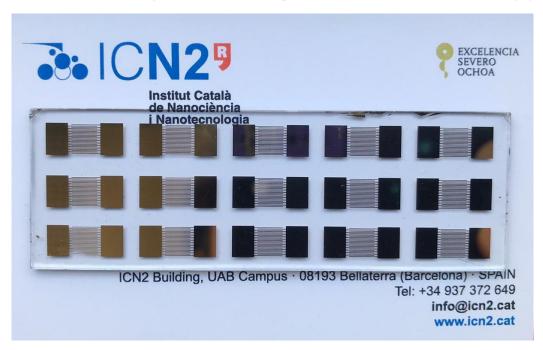
• Alignment accuracy: 1um



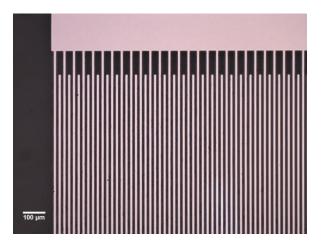


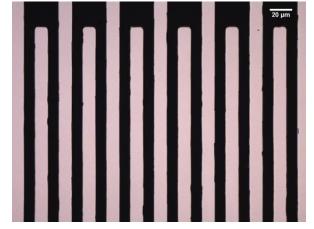
#### **Examples**

#### **AZ5214 thin positive/negative resist** – liftoff applications



15um- Au electrodes on glass (courtesy of Peng Xiao from P2N group)



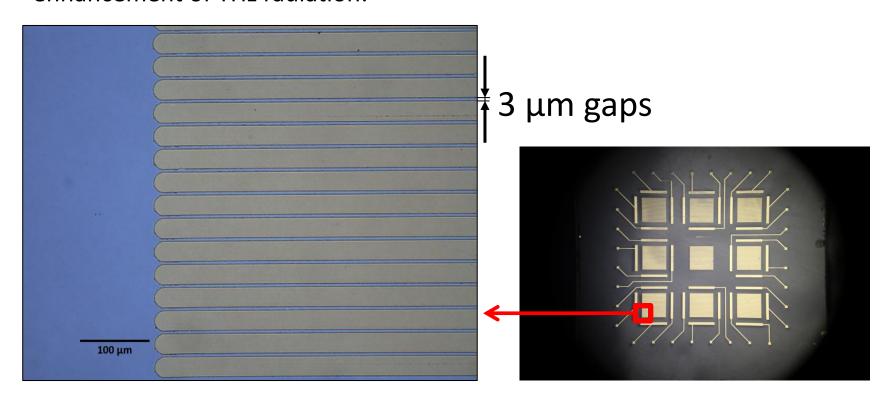




#### UV photolithography

#### **Examples**

Gratings (*Ti/Au*) are fabricated on topological insulator (TI) samples for field-enhancement of THz radiation:



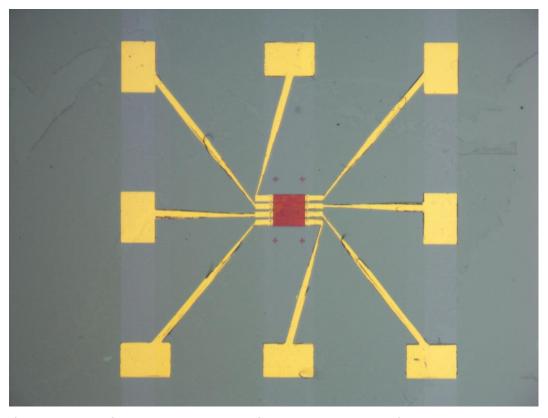
(courtesy of David Saleta from UDNS group)

**UV** photolithography



#### **Examples**

Au electrodes aligned on silicon with graphene and EBL previous pattern



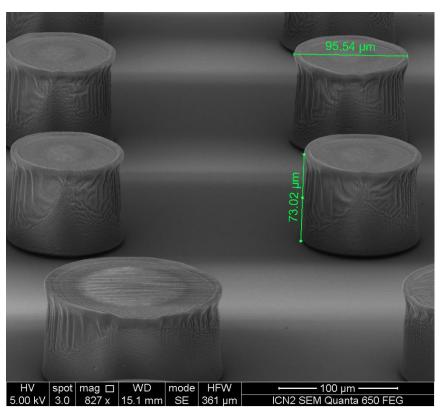
(courtesy of Nicolau Molina from AMS group)

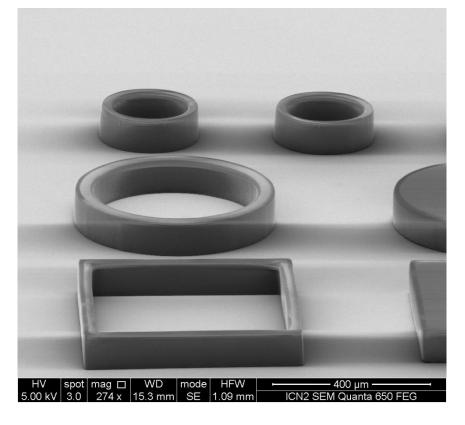




#### **Examples**

**SU-8 thick negative resist** - mainly used as master to make PDMS molds





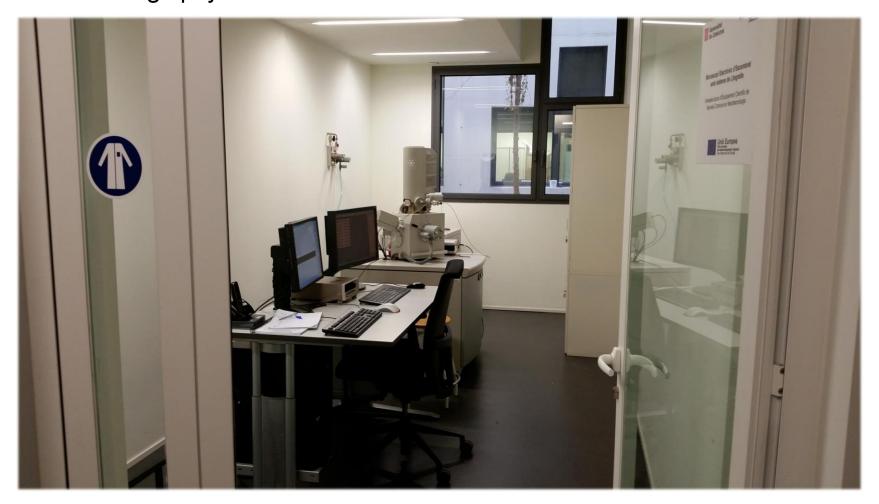
(courtesy of Nikolaos Kehagias from P2N group)

#### Systems outside the facility



E-beam lithography room

Room -1024



#### Systems outside the facility

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#### **Ebeam Lithography System**

SEM based ebeam lithography patterning.

Manufacturer: Raith GmbH.

Model: Elphy Quantum (Inspect F50 FEI SEM based)

High stability FE tip.

• *HV range*: 500V to 30kV

• *Current*: 0.6pA to 100nA.

6MHz Dual DAC to adress x-y beam deflection

• Writefield Sizes: from 25x25μm to 1x1mm.

High speed beam blanker (50MHz)

• Multiuser software management





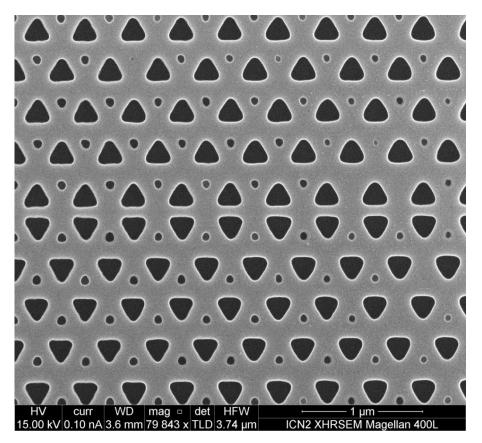
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#### Ebeam lithography

#### **Examples**

**Topological structure fabricated on silicon:** A photonic crystal where inversion symmetry of the periodic structure is broken.

All the fabrication steps done at ICN2, the electron beam lithography and etching.



(courtesy of David Garcia from P2N group)

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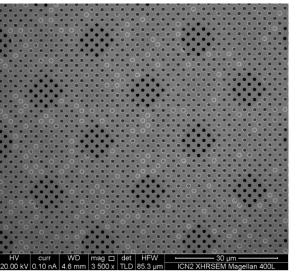
#### Ebeam lithography

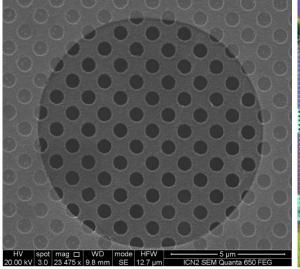
#### **Examples**

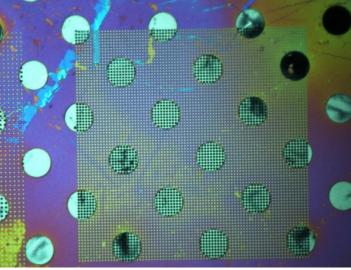
**Free-standing Polycrystalline MoS2 holy membrane**: EBL+RIE+Water-assisted transfer tech.

Study the thermal conductivity of free-standing polycrystalline MoS2 holey membrane.

All the fabrication steps done at ICN2, the electron beam lithography and etching.







(courtesy of Peng Xiao from P2N group)

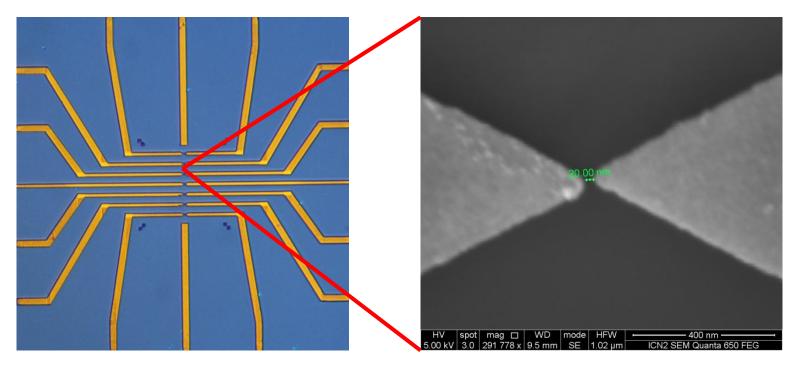
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#### Ebeam lithography

#### **Examples**

Graphene nanoribbon (GNR)-based Field Effect Transistors (FET). The distance between drain-source electrodes is controlled down to 20 nm via either arrows (left figure) or parallel finger-electrodes in order to contact single-GNR.

All the fabrication steps done at ICN2, the electron beam lithography and metallization.



(courtesy of Jose Ramón García from AMS group)





#### **Research support facilities**

MOLECULAR SPECTROSCOPY AND OPTICAL MICROSCOPY FACILITY

NANOFABRICATION FACILITY

#### www.icn2.cat/en/nanofabrication-facility-overview

PHOTOEMISSION SPECTROSCOPY (XPS&UPS) FACILITY

**BIOLAB FACILITY** 

X-RAY DIFFRACTION FACILITY